AMENDMENTS TO THE SPECIFICATION:

Please insert the following new paragraph at page 1, line 4, of the specification:

This is a Divisonal of copending application Serial No. 09/862,364, filed on May 22, 2001, the entire disclosure of which is incorporated herein by reference.

Please insert the following paragraph at page 7, line 20, of the specification:

FIG. 5 is a block diagram exemplary of in-circuit testing, in accordance with embodiments of the present invention.

Please replace the text at page 9, lines 3-15, of the specification with the following amended paragraph:

Referring now to **FIG.** 2, an embodiment of the coupon tester 200 of the present invention is illustrated. In accordance with the embodiment illustrated, the coupon 120 tested with a fast high-accuracy computer controllable LCR meter 206 (such as the commercially available Agilent 4287A LCR meter) and a scaleable, motion-controlled probing mechanism mounted on the top plate of a pneumatic fixture 208. The pneumatic fixture 208 preferably doubles as a highly accurate reference platform, adapting the panel 100 to an ICT machine. Such an ICT machine usually probes the circuit boards in panel 100 from below to conduct an in-circuit test. The motion-controlled probing mechanism of the coupon tester 200 sits atop the ICT machine (e.g,. the Agilent 3070 series) with the entire coupon test preferably occurring in parallel with standard in-circuit testing and sharing the pneumatic fixture 208 to hold the panel 100 in place in a desired orientation. An exemplary illustration of such a configuration 500 with an ICT machine is shown in FIG. 5 in which an ICT machine 502 is used to test circuit boards of a panel 100 plus a coupon to be tested 120, part of coupon tester 200. As shown, the coupon tester 200, with panel and coupon 100, 120 is held in place by fixture 208 for testing by ICT machine 502.